

Search Notes



Application/Control No.

10/682,015

Examiner

James Phan

Applicant(s)/Patent under
Reexamination

DEWA ET AL.

Art Unit

2872

SEARCHED

Class	Subclass	Date	Examiner
359	198	5/05	J.P.
	199		
	223-		
	226		
310	36,40R		
	40MM		
	152		
	311		
335	229		
	302		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All above		5/05	J.P.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST. See attachments	5/05	J.P.